

# Compressive Direct Measurement of the Transverse Photonic Wavefunction

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**Abstract:** We generalize the method of direct measurement and combine it with compressive sensing. Using our method, we measure a 19200-dimensional state using only 20% of the total required measurements.

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Determining an unknown wavefunction is of fundamental importance in quantum mechanics. Despite many seminal contributions, this task remains challenging for high-dimensional states. The direct measurement (DM) approach, introduced by Lundeen *et. al*, has provided a ground for meeting the high-dimensionality challenge [1]. Contrary to state tomography, this methods does not require a time-consuming post-processing. Nevertheless, the number of measurements required by the direct measurement protocol grows linearly with the dimensionality of the measured state. Here we combine a novel computational method known as compressive sensing with the direct measurement technique. Utilizing our approach, the wavefunction of a high-dimensional state can be estimated with a high fidelity using much fewer number of measurements compared to the standard direct measurement.

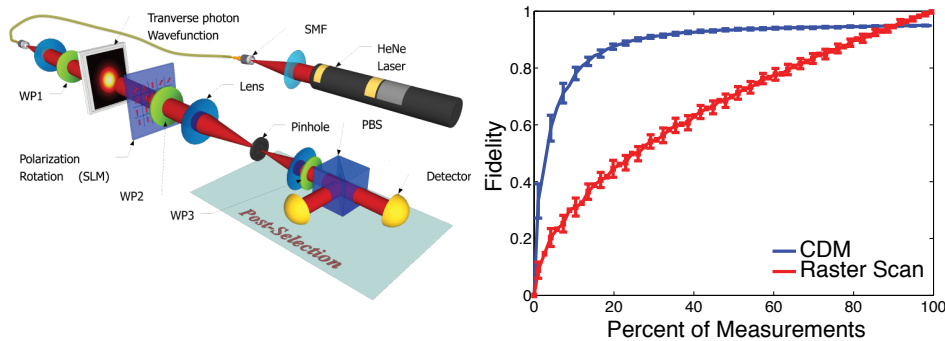


Fig. 1. A schematic illustration of the experimental setup (left). The fidelity of a reconstructed Gaussian state with the target wavefunction, shown in blue, as a function of the percentage of the total measurements (right). The fidelity of the state reconstructed from a partial pixel-by-pixel scan with the same number of measurements is shown in red for comparison.

A weak value is the expectation value of a weak measurement that is followed by a post-selection [2]. Consider a weak measurement of the position projector  $\hat{\pi}_j = |x_j\rangle\langle x_j|$  at point  $x_j$  followed by a post-selection on the zeroth component of the Fourier transform of the spatial wavefunction, which we denote by  $|\phi\rangle$ . The complex wavefunction of a photon can be calculated at each point by measuring the real and imaginary part of the weak value as

$$\pi_w = \frac{\langle \phi | x_j \rangle \langle x_j | \Psi \rangle}{\langle \phi | \Psi \rangle} = \frac{\Psi(x_j)}{\phi_0 \sqrt{N}}. \quad (1)$$

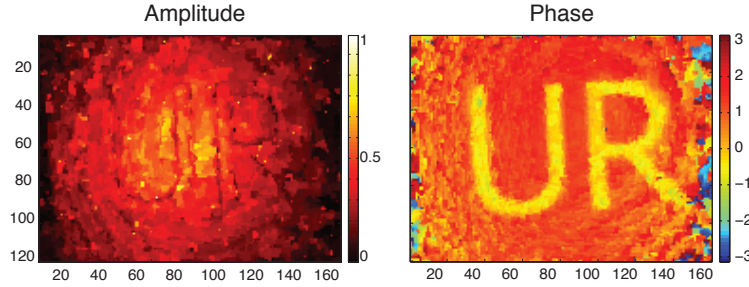


Fig. 2. The amplitude and phase of a Gaussian mode illuminating a custom phase mask (the initials of the University of Rochester). The data is reconstructed by the CDM method with  $N=19200$ , and  $M/N = 20\%$  of total measurements.

Here we have used the Fourier transform property  $\langle o|x_j \rangle = 1/\sqrt{N}$  where  $N$  is the dimension of the Hilbert space and  $\phi_0 = \langle o|\psi \rangle$ .

We generalize the DM to a form suitable for compressive sensing. Let the initial system-pointer state be  $|\Omega\rangle = |\psi\rangle \otimes |V\rangle = \sum_{i=1}^N \psi_i |x_i\rangle \otimes |V\rangle$ , where we have assumed to have a discrete Hilbert space for the spatial degree of freedom  $|\psi\rangle$  and a two-level system such as the polarization of a single photon for the pointer state  $|V\rangle$ . We consider a situation where instead of a measuring a projector  $\hat{\pi}_j$  we perform a weak measurement of the operator  $\hat{Q}_m = \sum_j Q_{m,j} \hat{\pi}_j$  where the coefficients  $Q_{m,j} \in \mathbb{R}$ . In this situation the imaginary and the real part of  $\psi_j$ ,  $\Im[\psi_j]$  and  $\Re[\psi_j]$ , can be related to the expectation values of the polarization of the post-selected state  $\bar{\sigma}_{x,m}$  and  $\bar{\sigma}_{y,m}$  via a linear set of equations  $\phi = \mathbf{Q} \psi$ .

Here,  $\phi_m = \frac{1}{\kappa} [\bar{\sigma}_{x,m} + i\bar{\sigma}_{y,m}]$  and  $\kappa = \frac{2\alpha}{\phi_0\sqrt{N}}$ . The numbers  $m \in \{1 : M\}$  and  $n \in \{1 : N\}$ , where  $M$  is the total number of sensing operators and  $N$  is the dimension of the Hilbert state of the unknown wavefunction. To find the wavefunction  $\psi$  we need to (approximately) solve this linear system of equations in the case where  $M \ll N$ . A nonlinear strategy can be used to recover  $\psi$  with a high quality using the idea of compressive sensing (CS). If the wavefunction under the experiment  $\psi$  is known to have very few non-zero coefficients under a linear transformation  $\mathbf{T}$ , it can be reconstructed with a high probability by solving the convex optimization problem [3]

$$\min_{\psi'} \|\mathbf{T}\psi'\|_{\ell_1}, \text{ subject to } \mathbf{Q}\psi' = \phi. \quad (2)$$

Fig. 1 shows the schematics of the experiment. A vertically polarized Gaussian mode is prepared by spatially filtering a He-Ne laser beam with a single mode fiber and passing it through a polarizer. A random polarization rotation at each point is performed using a spatial light modulator (SLM) in combination with two quarter wave plates (QWP) [4]. To provide a quantitative comparison of the two methods we calculate the fidelity between a retrieved Gaussian state  $|\psi'\rangle$  and the state  $|\psi\rangle$  from a full pixel-by-pixel scan (See Fig. 1). We prepare a custom target state by illuminating phase mask depicting letters U and R with a phase jump of  $\pi/2$  with a Gaussian beam. Figure 2 shows the amplitude and the phase of the reconstructed state with  $M/N = 20\%$  of the total measurements. Notice that while the amplitude is relatively uniform, the phase shows the letters U and R with a remarkable accuracy.

To conclude, we have demonstrated high fidelity reconstruction of spatial states using the compressive direct measurement (CDM) method. This technique can be used for measurement of high-dimensional quantum states as well as classical applications such as wavefront sensing.

## References

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